

ORSO example fit

We use the `anaklasis` package to fit the ORSO example data (data file `ORSO_example.ort`) that contains 4-column data (Q, R, dR, dQ). The data come from a Neutron Reflectivity measurement of a $\text{Si/SiO}_2/\text{Polymer/D}_2\text{O}$ system.

we first import `anaklasis.ref`

```
In [1]: from anaklasis import ref
```

we then name the project, import input data, set Q units in Angstrom (as they are in the input file) and also set pointwise resolution since our file contains dQ data.

```
In [2]: project='ORSO_example'
in_file=['ORSO_example.ort']
units=['Å'] # Angstrom units
resolution=[-1] # pointwise resolution
```

we then create our model where we assume that the polymer layer has no solvent penetration.

```
In [3]: model=[
# Re_sld Im_sld thk rough solv description
[ 2.07e-6, 0.0, 0, 'p0', 0.0, 'Si1'],
[ 3.07e-6, 0.0, 'p1', 'p2', 0.0, 'SiO2'],
[ 'p3', 0.0, 'p4', 'p5', 0.0, 'Polymer'],
[ 6.35e-6, 0.0, 0, 0, 1.0, 'D2O'],
]
```

We have a single model in the system covering uniformly the whole substrate (single patch), so

```
In [4]: system=[model]
patches=[1.0]
```

we have entered 6 parameters in total in the model. Let's define their bounds together with their descriptions. Note that we consider that all parameters have a uniform probability to assume a value between the declared bounds.

```
In [5]: global_param = [
# param min max description type
['p0', 0, 5, 'Si_SiO2_roughness', 'uniform'],
['p1', 0, 100, 'SiO2_thickness', 'uniform'],
['p2', 0, 50, 'SiO2_Polymer_roughness', 'uniform'],
['p3', -0.5e-6, 3.0e-6, 'Polymer_sld', 'uniform'],
['p4', 0, 700, 'Polymer_thickness', 'uniform'],
['p5', 0, 80, 'Polymer_D2O_roughness', 'uniform'],
]
```

although not necessary, we may require that the thickness of the SiO_2 and polymer layers stays always larger than their roughness. We can do that using two inequality constraints

```
In [6]: constraints = ['p1>p2', 'p4>p5']
```

We have no multi-parameters to declare (they are usually used for multiple contrast refinements), so

```
In [7]: multi_param = [] # no multi-parameters
```

We then leave the scale and the background a bit free to vary during the refinement

```
In [8]: background = [[0.0, 1.0e-6, 'uniform']]
scale = [[0.9, 1.1, 'uniform']]
```

Then we set the fit details and call the `ref.fit` function to perform the data refinement

```
In [9]: fit_mode=0 # using FOM1
fit_weight=[1]
method='simple' # Uncertainty estimated through Hessian matrix

res = ref.fit(project, in_file, units, fit_mode,
fit_weight, method, resolution, patches, system,
global_param, multi_param, constraints,
background, scale, experror=True)
```

Program ANAKIASIS - Fit Module for X-ray/Neutron reflection datasets
version 1.4, June 2021
developed by Dr. Alexandros Koutsoumpas. JCNS 8 MLZ
for bugs and requests contact: a.koutsoumpas[at]jz-juelich.de

Project name: ORSO_example
Using chi squared with errors figure of merit (FOM)
Fast fit mode. Using small differential evolution population size
Parameter uncertainty calculation by Hessian matrix estimation
A plot summarizing results will pop-up after the end of the calculation

Directory already exists.. overwriting data..
file#0 experimental points: 408
Q units in inverse Å
dQ/Q pointwise
fit weight: 1
free parameters = 8

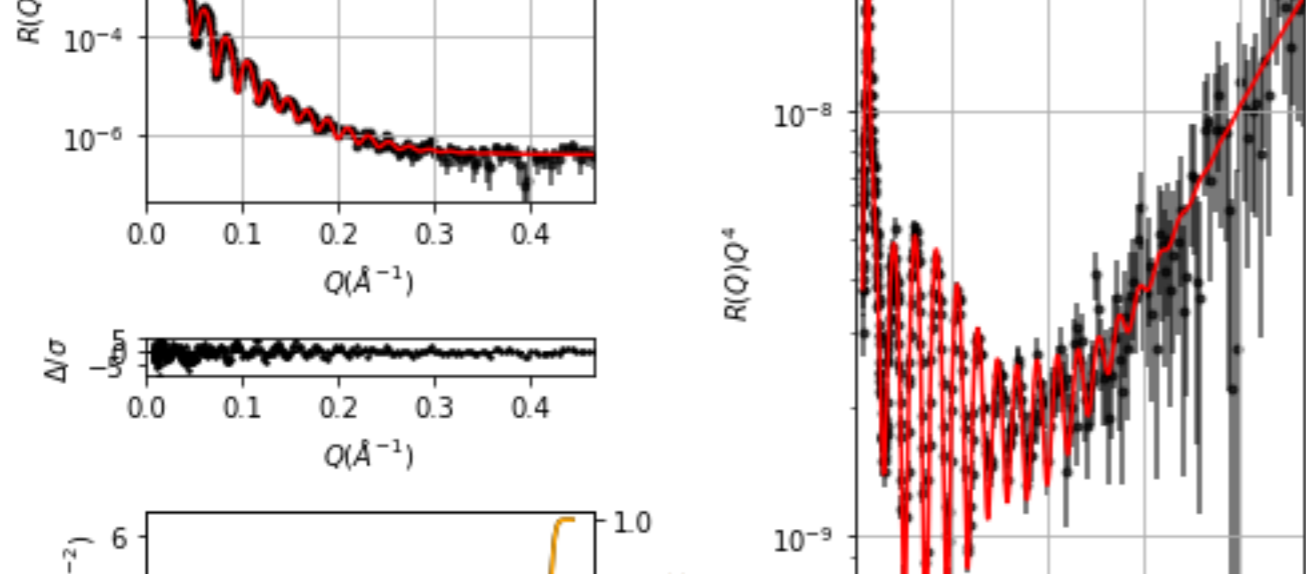
list of free parameters: p0 (Si_SiO2_roughness), p1 (SiO2_thickness), p2 (SiO2_Polymer_roughness), p3 (Polymer_sld), p4 (Polymer_thickness), p5 (Polymer_D2O_roughness), bkg curve#0, scale curve#0,

Running differential evolution minimization...

/n
Success: True

Number of evaluation: 5799
Number of iterations: 50
FOM: 3.2403608133807076

Estimating Hessian matrix...



Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 4.69 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
SiO2 thickness (Å) = 39.30 (parametric), -> p1
SiO2/Polymer roughness (Å) = 10.21 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.45 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 258.18 (parametric), -> p4
Polymer/D2O roughness (Å) = 3.79 (parametric), -> p5
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $3.87e-07 \pm 3.05e-07$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.04e-01 \pm 4.03e-02$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

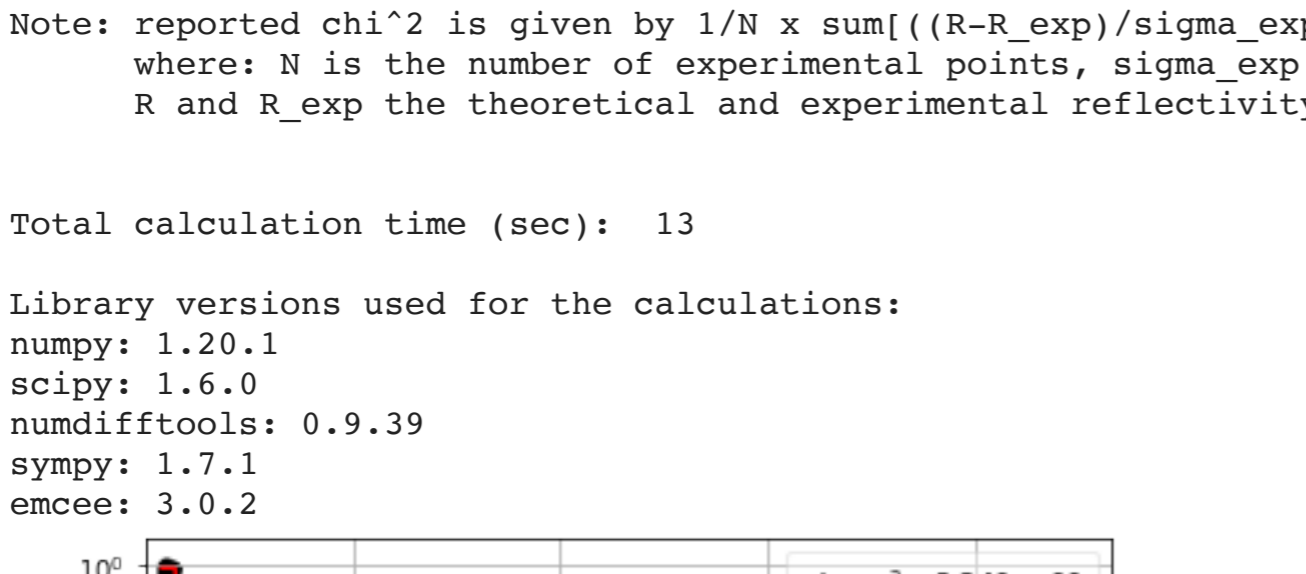
Si_SiO2_roughness: p0 = $4.69e+00 \pm 5.65e+00$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.93e+01 \pm 2.47e+00$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $1.02e+01 \pm 5.36e+00$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.45e-06 \pm 7.14e-07$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.58e+02 \pm 1.83e+00$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.79e+00 \pm 1.28e+00$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.24e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
R and R_exp the theoretical and experimental reflectivity respectively.

Total calculation time (sec): 13

Library versions used for the calculations:
numpy: 1.20.1
scipy: 1.6.0
numdiff: 0.9.39
sympy: 1.7.1
emcee: 3.0.2



Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 5.00 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
SiO2 thickness (Å) = 38.12 (parametric), -> p1
SiO2/Polymer roughness (Å) = 8.41 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.47 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 259.67 (parametric), -> p4
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $4.33e-07 \pm 1.95e-08$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.00e-01 \pm 3.70e-04$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

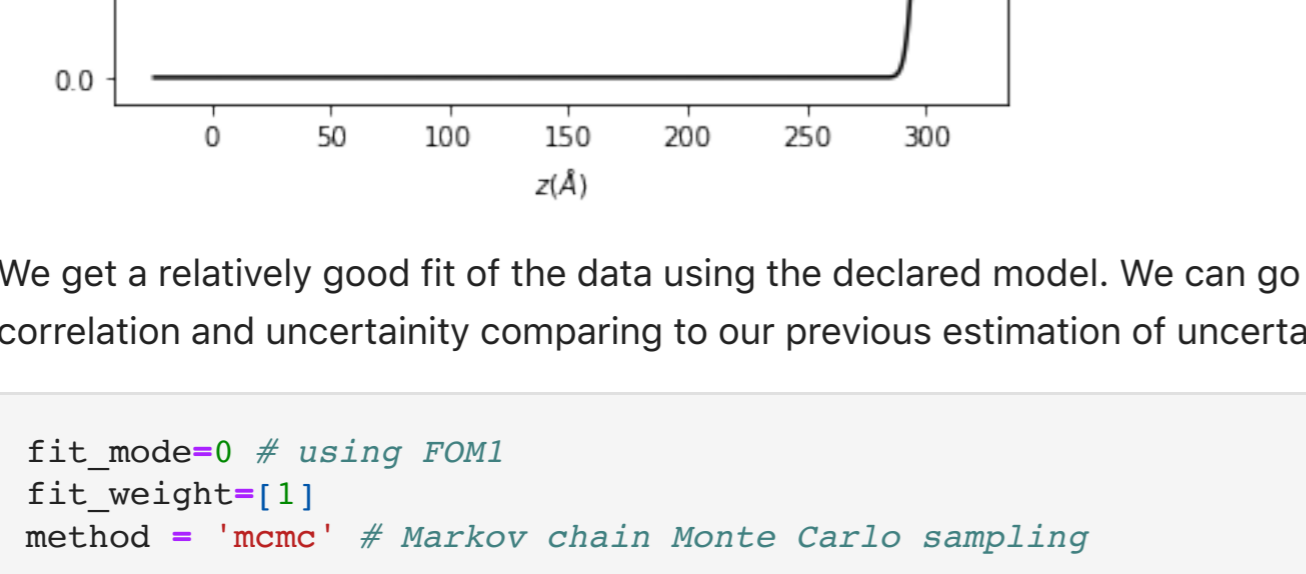
Si_SiO2_roughness: p0 = $5.00e+00 \pm 2.56e-02$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.81e+01 \pm 3.62e-01$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $8.41e+00 \pm 3.41e-01$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.47e-06 \pm 9.54e-09$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.60e+02 \pm 2.47e-01$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.39e+00 \pm 9.31e-02$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.07e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
R and R_exp the theoretical and experimental reflectivity respectively.

Total calculation time (sec): 227

Library versions used for the calculations:
numpy: 1.20.1
scipy: 1.6.0
numdiff: 0.9.39
sympy: 1.7.1
emcee: 3.0.2



Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 5.00 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
SiO2 thickness (Å) = 38.12 (parametric), -> p1
SiO2/Polymer roughness (Å) = 8.41 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.47 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 259.67 (parametric), -> p4
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $4.33e-07 \pm 1.95e-08$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.00e-01 \pm 3.70e-04$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

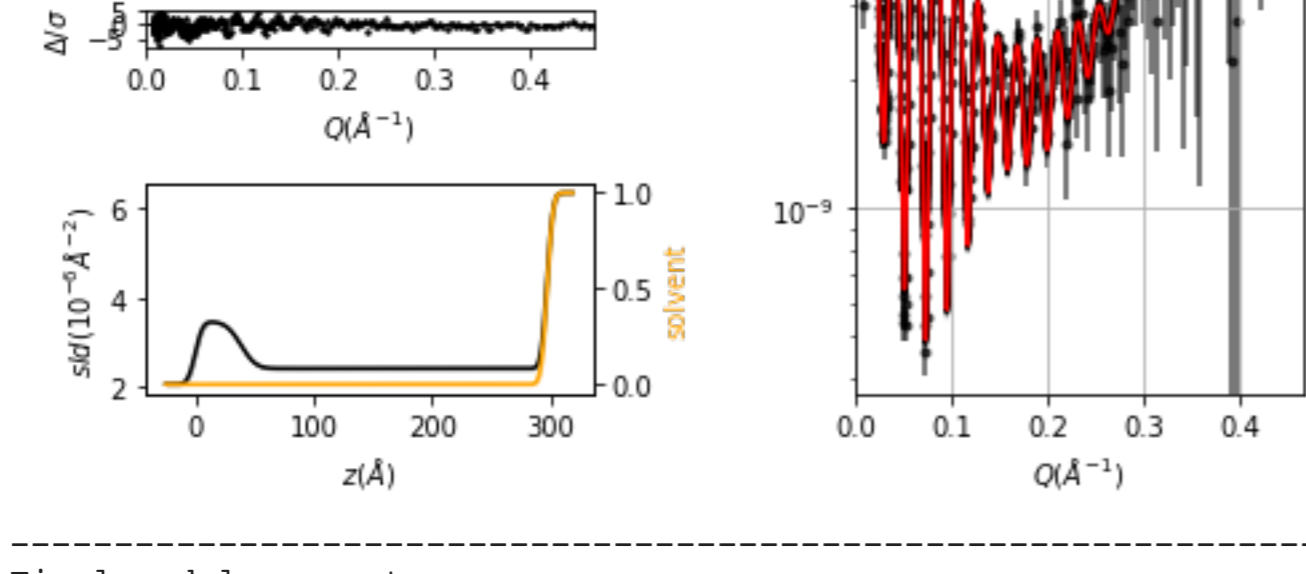
Si_SiO2_roughness: p0 = $5.00e+00 \pm 2.56e-02$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.81e+01 \pm 3.62e-01$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $8.41e+00 \pm 3.41e-01$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.47e-06 \pm 9.54e-09$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.60e+02 \pm 2.47e-01$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.39e+00 \pm 9.31e-02$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.07e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
R and R_exp the theoretical and experimental reflectivity respectively.

Total calculation time (sec): 227

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numpy: 1.20.1
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numdiff: 0.9.39
sympy: 1.7.1
emcee: 3.0.2



Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 5.00 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
SiO2 thickness (Å) = 38.12 (parametric), -> p1
SiO2/Polymer roughness (Å) = 8.41 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.47 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 259.67 (parametric), -> p4
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $4.33e-07 \pm 1.95e-08$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.00e-01 \pm 3.70e-04$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

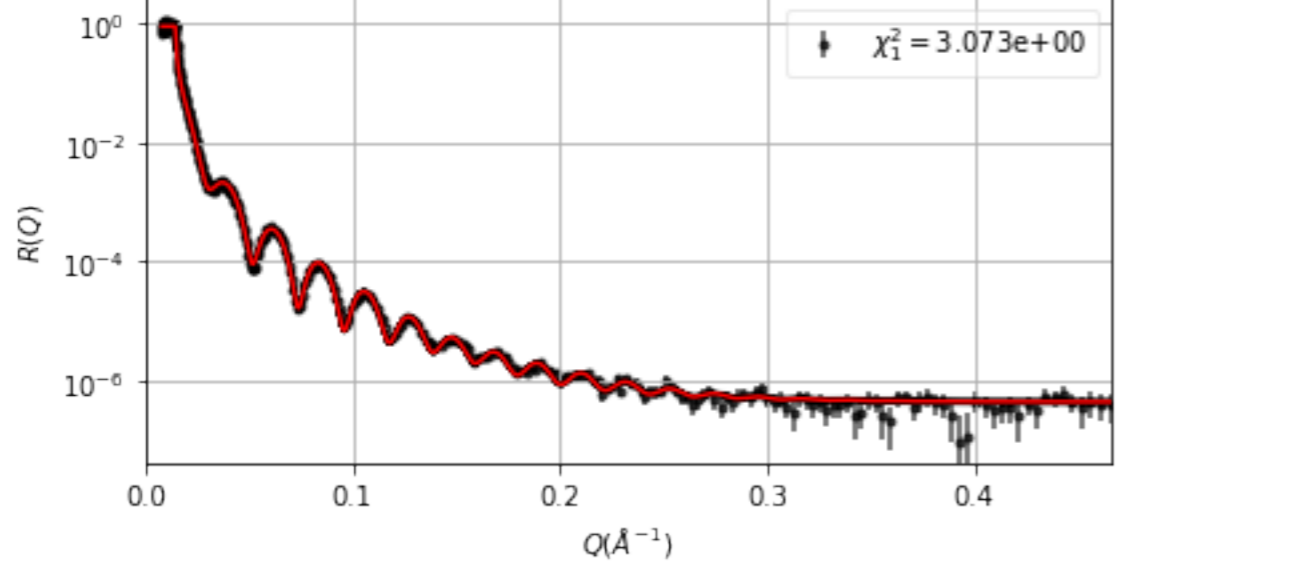
Si_SiO2_roughness: p0 = $5.00e+00 \pm 2.56e-02$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.81e+01 \pm 3.62e-01$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $8.41e+00 \pm 3.41e-01$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.47e-06 \pm 9.54e-09$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.60e+02 \pm 2.47e-01$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.39e+00 \pm 9.31e-02$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.07e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
R and R_exp the theoretical and experimental reflectivity respectively.

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numdiff: 0.9.39
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emcee: 3.0.2



Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
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Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
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SiO2 thickness (Å) = 38.12 (parametric), -> p1
SiO2/Polymer roughness (Å) = 8.41 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.47 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 259.67 (parametric), -> p4
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $4.33e-07 \pm 1.95e-08$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.00e-01 \pm 3.70e-04$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

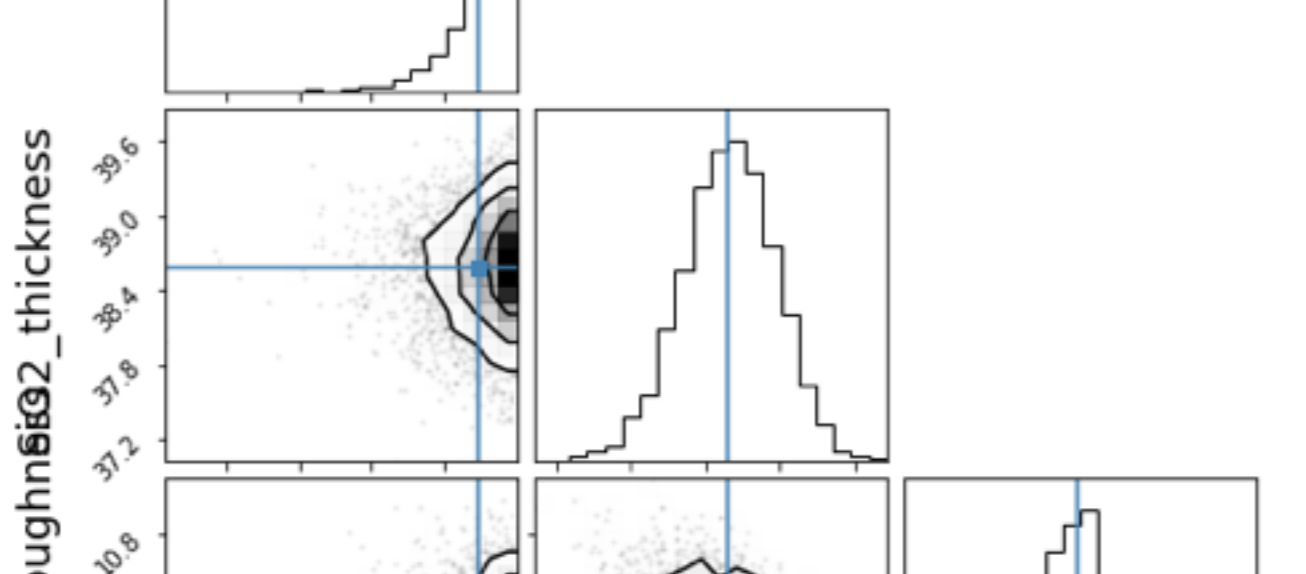
Si_SiO2_roughness: p0 = $5.00e+00 \pm 2.56e-02$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.81e+01 \pm 3.62e-01$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $8.41e+00 \pm 3.41e-01$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.47e-06 \pm 9.54e-09$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.60e+02 \pm 2.47e-01$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.39e+00 \pm 9.31e-02$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.07e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
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emcee: 3.0.2



Final model parameters

Curve #0

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fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 5.00 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
SiO2 thickness (Å) = 38.12 (parametric), -> p1
SiO2/Polymer roughness (Å) = 8.41 (parametric), -> p2
SiO2 solvent volume fraction = 0.00 (fixed)

Polymer real sld (10^{-6} Å^{-2}) = 2.47 (parametric), -> p3
Polymer imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Polymer thickness (Å) = 259.67 (parametric), -> p4
Polymer solvent volume fraction = 0.00 (fixed)

D2O real sld (10^{-6} Å^{-2}) = 6.35 (fixed)
D2O imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
D2O solvent volume fraction = 1.00 (fixed)

Background: = $4.33e-07 \pm 1.95e-08$, bounds: 0.0 -> $1e-06$ (uniform)
Scale: = $9.00e-01 \pm 3.70e-04$, bounds: 0.9 -> 1.1 (uniform)

Parameters:

Si_SiO2_roughness: p0 = $5.00e+00 \pm 2.56e-02$, bounds: 0.0 -> 5.0 (uniform)
SiO2_thickness: p1 = $3.81e+01 \pm 3.62e-01$, bounds: 0.0 -> 100.0 (uniform)
SiO2_Polymer_roughness: p2 = $8.41e+00 \pm 3.41e-01$, bounds: 0.0 -> 50.0 (uniform)
Polymer_sld: p3 = $2.47e-06 \pm 9.54e-09$, bounds: $-5e-07$ -> $3e-06$ (uniform)
Polymer_thickness: p4 = $2.60e+02 \pm 2.47e-01$, bounds: 0.0 -> 700.0 (uniform)
Polymer_D2O_roughness: p5 = $3.39e+00 \pm 9.31e-02$, bounds: 0.0 -> 80.0 (uniform)

curve#0 chi^2 = 3.07e+00

Note: reported chi^2 is given by $1/N \times \sum((R-R_{\text{exp}}/\sigma_{\text{exp}})^2)$
where: N is the number of experimental points, sigma_exp the experimental uncertainty
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Final model parameters

Curve #0

Instrumental Resolution, dQ/Q: pointwise
fit weigh: 1

Si real sld (10^{-6} Å^{-2}) = 2.07 (fixed)
Si imaginary sld (10^{-6} Å^{-2}) = 0.00 (fixed)
Si thickness (Å) = 0.00 (fixed)
Si/SiO2 roughness (Å) = 5.00 (parametric), -> p0
Si solvent volume fraction = 0.00 (fixed)

SiO2 real sld (10^{-6} Å^{-2}) = 3.47 (fixed)
SiO2 imaginary